## TOSHIBA MOS DIGITAL INTEGRATED CIRCUIT SILICON GATE CMOS

## 131,072-WORD BY 8-BIT CMOS STATIC RAM

### DESCRIPTION

The TC558128BJ/BFT is a 1,048,576-bit high-speed static random access memory (SRAM) organized as 131,072 words by 8 bits. Fabricated using CMOS technology and advanced circuit techniques to provide high speed, it operates from a single 5 V power supply. There are two control inputs. Chip enable ( $\overline{CE}$ ) can be used to place the device in a low-power mode, and output enable  $(\overline{OE})$  provides fast memory access. This device is well suited to cache memory applications where high-speed access and high-speed storage are required. All inputs and outputs are directly TTL compatible. The TC558128BJ/BFT is available in a plastic 32-pin SOJ (400 mil width) and TSOP packages for high density surface assembly.

### FEATURES

Fast access time (the following are maximum values) • Single power supply voltage of 5 V  $\pm$  10%. TC558128BJ/BFT-12: 12 ns • Fully static operation

TC558128BJ/BFT-15: 15 ns

- Low-power dissipation
  - (the following are maximum values)

Cycle Time	12	15	20	25	30	ns
Operation (max)	1 <b>9</b> 0	170	140	130	120	mA

Standby: 1 mA (both devices)

#### **PIN ASSIGNMENT**



- All inputs and outputs are TTL compatible
- Output buffer control using  $\overline{OE}$
- Package:

SOJ32-P-400-1.27A (BJ) (Weight: 1.22 g typ) TSOP II 32-P-400-0.80C (BFT) (Weight: 0.34 g typ)

### **PIN NAMES**

A0 to A16	Address Inputs
I/01 to I/08	Data Inputs/Outputs
CE	Chip Enable
WE	Write Enable Input
ŌĒ	Output Enable
V <sub>DD</sub>	Power (+ 5 V)
GND	Ground

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## **BLOCK DIAGRAM**



## **MAXIMUM RATINGS**

RATING	VALUE	UNIT
Power Supply Voltage	– 0.5 to 7.0	V
Input Terminal Voltage	– 2.0 * to 7.0	v
Input/Output Terminal Voltage	- 0.5 * to V <sub>DD</sub> + 0.5	V
Power Dissipation	1.1	W
Soldering Temperature (10 s)	260	°C
Storage Temperature	– 65 to 150	°C
Operating Temperature	– 10 to 85	°C
	Power Supply Voltage         Input Terminal Voltage         Input/Output Terminal Voltage         Power Dissipation         Soldering Temperature (10 s)         Storage Temperature	Power Supply Voltage- 0.5 to 7.0Input Terminal Voltage- 2.0* to 7.0Input/Output Terminal Voltage- 0.5* to V <sub>DD</sub> + 0.5Power Dissipation1.1Soldering Temperature (10 s)260Storage Temperature- 65 to 150

\*: -3 V with a pulse width of 10 ns

## <u>DC RECOMMENDED OPERATING CONDITIONS</u> (Ta = $0^{\circ}$ to $70^{\circ}$ C)

SYMBOL	PARAMETER	MIN	TYP	MAX	UNIT
V <sub>DD</sub>	Power Supply Voltage	4.5	5.0	5.5	v
V <sub>IH</sub>	Input High Voltage	2.2	-	V <sub>DD</sub> + 0.5	v
V <sub>IL</sub>	Input Low Voltage	- 0.5 *	-	0.8	v

\*: -3 V with a pulse width of 10 ns

## <u>DC CHARACTERISTICS</u> (Ta = $0^{\circ}$ to $70^{\circ}$ C, V<sub>DD</sub> = 5 V ± 10%)

SYMBOL	PARAMETER	TEST CONDITION		MIN	ТҮР	МАХ	UNIT
I <sub>IL</sub>	Input Leakage Current	$V_{IN} = 0 V$ to $V_{DD}$		_	-	± 10	μA
I <sub>LO</sub>	Output Leakage Current	$\overline{CE} = V_{IH} \text{ or } \overline{WE} = V_{IL} \text{ or } \overline{CE}$ $V_{OUT} = 0 \text{ V to } V_{DD}$	OE = V <sub>IH</sub>	-	-	± 10	μΑ
I <sub>ОН</sub>	Output High Current	V <sub>OH</sub> = 2.4 V		- 4	Ι	-	mA
I <sub>OL</sub>	Output Low Current	V <sub>OL</sub> = 0.4 V		8	Ι	-	mA
			tcycle = 12 ns	-	-	190	
		$\overline{CE} = V_{IL}$ , lout = 0 mA	tcycle = 15 ns	-	-	170	
IDDO	Operating Current	$CE = V_{IL}$ , $IOUT = 0 IIIA$	tcycle = 20 ns	-	-	140	mA
		Other Inputs = $V_{IH}$ or $V_{IL}$	tcycle = 25 ns	-	-	130	
			tcycle = 30 ns	-	-	120	
I <sub>DDS1</sub>		$\overline{CE} = V_{IH}$ , Other Inputs = $V_{IH}$ or $V_{IL}$		_	_	30	
I <sub>DDS2</sub>	Standby Current	$\overline{CE} = V_{DD} - 0.2 V$ Other Inputs = $V_{DD} - 0.2$			_	1	mA

## <u>CAPACITANCE</u> (Ta = 25°C, f = 1.0 MHz)

SYMBOL	PARAMETER	TEST CONDITION	МАХ	UNIT
C <sub>IN</sub>	Input Capacitance	V <sub>IN</sub> = GND	6	pF
C <sub>I/O</sub>	Input/Output Capacitance	$V_{1/O} = GND$	8	pF

Note: This parameter is periodically sampled and is not 100% tested.

## **OPERATING MODE**

MODE	CE	ŌĒ	WE	I/O1 to I/O8	POWER
Read	L	L	н	Output	I <sub>DDO</sub>
Write	L	×	L	Input	I <sub>DDO</sub>
Outputs Disable	L	Н	Н	High Impedance	I <sub>DDO</sub>
Standby	н	×	×	High Impedance	I <sub>DDS</sub>

 $\times$ : Don't care

# <u>AC CHARACTERISTICS</u> (Ta = $0^{\circ}$ to $70^{\circ}C^{\text{(Note 1)}}$ , $V_{DD} = 5 \text{ V} \pm 10\%$ )

## READ CYCLE

SYMBOL	PARAMETER	TC558128	BJ/BFT-12	TC558128	UNIT	
STIVIBOL	FANAIVIETEN	MIN	MAX	MIN	MAX	UNIT
t <sub>RC</sub>	Read Cycle Time	12	-	15	_	
t <sub>ACC</sub>	Address Access Time	-	12	-	15	
t <sub>CO</sub>	Chip Enable Access Time	-	12	-	15	
t <sub>OE</sub>	Output Enable Access Time	-	6	-	8	
t <sub>OH</sub>	Output Data Hold Time from Address Change	5	-	5	-	ns
t <sub>COE</sub>	Output Enable Time from Chip Enable	5	-	5	_	
t <sub>OEE</sub>	Output Enable Time from Output Enable	1	-	1	-	
t <sub>COD</sub>	Output Disable Time from Chip Enable	-	6	-	8	
t <sub>ODO</sub>	Output Disable Time from Output Enable	-	6	-	8	

#### WRITE CYCLE

SYMBOL	PARAMETER		BJ/BFT-12	TC558128		
STIVIBOL	PARAIVIETER	MIN	МАХ	MIN	МАХ	UNIT
t <sub>WC</sub>	Write Cycle Time	12	-	15	-	
t <sub>WP</sub>	Write Pulse Width	8	-	9	-	
t <sub>CW</sub>	Chip Enable to End of Write	10	-	12	-	
t <sub>AW</sub>	Address Valid to End of Write	10	-	12	_	
t <sub>AS</sub>	Address Setup Time	0	-	0	-	
t <sub>WR</sub>	Write Recovery Time	0	-	0	-	ns
t <sub>DS</sub>	Data Setup Time	6	-	8	-	
t <sub>DH</sub>	Data Hold Time	0	_	0	_	
t <sub>OEW</sub>	Output Enable Time from Write Enable	1	-	1	-	
t <sub>ODW</sub>	Output Disable Time from Write Enable	_	6	_	8	

## AC TEST CONDITIONS

Input Pulse Level	3.0 V, 0.0 V
Input Pulse Rise and Fall Time	3 ns
Input timing Measurement Reference Level	1.5 V
Output Timing Measurement Reference Level	1.5 V
Output Load	Fig. 1



## **TIMING DIAGRAMS**

READ CYCLE (See Note 2)



#### WRITE CYCLE 1 (WE CONTROLLED) (See Note 5)



## WRITE CYCLE 2 (CE CONTROLLED) (See Note 5)



- Note: (1) Operating temperature (Ta) is guaranteed for transverse air flow exceeding 400 linear feet per minute.
  - (2)  $\overline{\text{WE}}$  remains HIGH for the Read Cycle.
  - (3) If  $\overline{CE}$  goes LOW coincident with or after  $\overline{WE}$  goes LOW, the outputs will remain at high impedance.
  - (4) If  $\overline{CE}$  goes HIGH coincident with or before  $\overline{WE}$  goes HIGH, the outputs will remain at high impedance.
  - (5) If  $\overline{OE}$  is HIGH during the write cycle, the outputs will remain at high impedance.
  - (6) The parameters specified below are measured using the load shown in Fig. 1.
    - (A) t<sub>COE</sub>, t<sub>OEE</sub>, t<sub>OEW</sub> Output ..... Enable Time
    - (B) t<sub>COD</sub>, t<sub>ODO</sub>, t<sub>ODW</sub> Output ..... Disable Time



## PACKAGE DIMENSIONS

Plastic SOJ (SOJ32-P-400-1.27A)

Units in mm



Weight: 1.22 g (typ)

## PACKAGE DIMENSIONS

Plastic TSOP (TSOP II 32-P-400-0.80C)

Units in mm



Weight: 0.34 g (typ)